Schedule of Accreditation

issued by

United Kingdom Accreditation Service

2 Pine Trees, Chertsey Lane, Staines-upon-Thames, TW18 3HR, UK



0556

Accredited to ISO/IEC 17025:2017

Horiba MIRA Limited

Issue No: 032 Issue date: 13 January 2025

Calibration Centre Contact: Mr Philip Macleod
Watling Street Tel: +44 (0)2476 355643
Nuneaton Fax: +44 (0)2476 358225

Warwickshire E-Mail: calibration.centre@horiba-mira.com

Website: www.horiba-mira.com

Calibration performed by the Organisation at the locations specified

Locations covered by the organisation and their relevant activities

Laboratory locations:

Location details		Activity	Location code
Address Calibration Centre Watling Street Nuneaton Warwickshire CV10 0TU	Local contact Contact: Mr Philip Macleod Tel: +44 (0)2476 355643 E-Mail:calibration.centre@horiba-mira.com Website: www.horiba-mira.com	Pressure Force Measuring Devices Accelerometery Electrical Angular rate Temperature Simulation	A

Site activities performed away from the locations listed above:

CV10 0TU

Location details		Activity	Location code
HORIBA Mira Limited other departments.	Mr Philip Macleod Tel: +44 (0)2476 355643	Electrical Temperature Simulation	В

Assessment Manager: DP4 Page 1 of 11



Schedule of Accreditation issued by

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Calibration and Measurement Capability (CMC)

Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
PRESSURE			Methods consistent with EURAMET CG17.	A
Gas Pressure Gauge			CG17.	
Calibration of pressure indicating instruments and gauges	-90 kPa to 0 Pa 0 to 2 MPa 2 MPa to 21 MPa	0.024 % + 0.59 kPa 0.024 % + 0.59 kPa 0.030 % + 2.1 kPa	Calibration of pressure devices with an electrical output can be undertaken	
Gas Pressure Absolute				
Calibration of pressure indicating instruments and gauges	10 kPa to 200 kPa 200 kPa to 2.1 MPa 2.1 MPa to 21.1 MPa	0.15 kPa 0.024 % + 0.60 kPa 0.030 % + 3.0 kPa		
Hydraulic Pressure Gauge				
Calibration of pressure indicating instruments and gauges	0 to 50 MPa	0.016 % + 90 kPa		
FORCE MEASURING DEVICES				A
Calibration of force measuring devices (e.g. strain gauged load cells, push pull gauges, and load measuring rings) but excluding proving devices by masses in tension and compression	9.8 N to 58.8 N 58.8 N to 978 N	0.11 % 0.28 %	Calibrated to documented in house methods	
Calibration of force measuring devices (e.g. strain gauged load cells, push pull gauges, and load measuring rings) but excluding proving devices by force proving instruments in tension and compression	978 N to 1.2 KN 1.2 kN to 30 kN	0.90 % 0.70 %	Calibrated to documented in house methods	
Calibration of force measuring devices (e.g. strain gauged load cells, push pull gauges, and load measuring rings) but excluding proving devices by force proving instruments in tension	30 kN to 300 kN	1.1 % + 0.00083 %FS	Calibrated to documented in house methods	
Calibration of force measuring devices (e.g. strain gauged load cells, push pull gauges, and load measuring rings) but excluding proving devices by force proving instruments in compression	30 kN to 600 kN	1.1 % + 0.00083 %FS	Calibrated to documented in house methods	

Assessment Manager: DP4 Page 2 of 11



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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty $(k = 2)$	Remarks	Location Code
ACCELERATION TRANSDUCERS			Calibration method is by direct comparison against laboratory references	
Transducer at 20 °C			10.0.0.1000	A
Accelerometer Types: Piezo electric minimum sensitivity >1 pC/m/s² Integral electronic minimum sensitivity >1 mV/m/s² Piezo resistive minimum sensitivity >1 mV/m/s²	1 Hz to 5 Hz 5 Hz to 5 kHz	2.0 % 1.7 %		
All types with a nominal mass of up to 100 grams, a nominal Peak Acceleration of 1.9 ms ⁻² to 147.1 ms ⁻² and a minimum sensitivity of 0.04 mV ms ⁻²				

the method used is by direct comp		n the remarks column.	ents and for instruments w	ıın an output.
ELECTRICAL				
DC VOLTAGE				
Generation	0 mV to 330 mV 330 mV to 3.3 V 3.3 V to 33 V 33 V to 330 V 330 V to 1000 V	20 μV/V + 1.0 μV 11 μV/V + 2.0 μV 12 μV/V + 20 μV 18 μV/V + 150 μV 18 μV/V + 1.5 mV		
Measurement	0 mV to 200 mV 200 mV to 2 V 2 V to 20 V 20 V to 200 V 200 V to 1000 V	12 μV/V + 1.2 μV 6.0 μV/V 5.0 μV/V 12 μV/V 12 μV/V		
AC VOLTAGE				
Generation	1 mV to 33 mV 0.2 Hz to 10 Hz 10 Hz to 45 Hz 45 Hz to 10 kHz 10 kHz to 20 kHz 20 kHz to 50 kHz 50 kHz to 500 kHz 100 kHz to 500 kHz	800 μV/V + 100 μV 800 μV/V + 100 μV 150 μV/V + 100 μV 200 μV/V + 100 μV 0.10 % + 100 μV 0.35 % + 110 μV 0.80 % + 150 μV		

Assessment Manager: DP4 Page 3 of 11



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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
ELECTRICAL (continued)				A
AC VOLTAGE (continued)				
Generation (continued)	33 mV to 330 mV 0.2 Hz to 10 Hz 10 Hz to 45 Hz 45 Hz to 10 kHz 10 kHz to 20 kHz 20 kHz to 50 kHz 50 kHz to 100 kHz 100 kHz to 500 kHz	300 μV/V + 120 μV 300 μV/V + 120 μV 150 μV/V + 120 μV 160 μV/V + 120 μV 350 μV/V + 120 μV 800 μV/V + 140 μV 0.20 % + 190 μV		
	0.33 V to 3.3 V 0.2 Hz to 10 Hz 10 Hz to 45 Hz 45 Hz to 10 kHz 10 kHz to 20 kHz 20 kHz to 50 kHz 50 kHz to 100 kHz 100 kHz to 500 kHz	300 μV/V + 400 μV 300 μV/V + 400 μV 150 μV/V + 400 μV 190 μV/V + 400 μV 300 μV/V + 400 μV 700 μV/V + 460 μV 0.24 % + 1.2 mV		
	3.3 V to 10.23 V 0.2 Hz to 10 Hz	300 μV/V + 4.5 mV		
	3.3 V to 33 V 10 Hz to 45 Hz 45 Hz to 10 kHz 10 kHz to 20 kHz 20 kHz to 50 kHz 50 kHz to 100 kHz	300 μV/V + 4.0 mV 150 μV/V + 4.0 mV 240 μV/V + 4.0 mV 350 μV/V + 4.0 mV 900 μV/V + 5.0 mV		
	33 V to 330 V 10 Hz to 45 Hz 45 Hz to 10 kHz 10 kHz to 20 kHz 20 kHz to 50 kHz 50 kHz to 100 kHz	190 μ V/V + 30 mV 200 μ V/V + 30 mV 250 μ V/V + 30 mV 300 μ V/V + 30 mV 0.20 % + 80 mV		
	330 V to 1020 V 45 Hz to 1 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz	300 μV/V + 120 mV 250 μV/V + 120 mV 300 μV/V + 120 mV		
AC Voltage Measurement				
	1 mV to 200 mV 20 Hz to 1 kHz 1 kHz to 10 kHz	0.057 % 0.046 %		
	200 mV to 2 V 20 Hz to 1 kHz 1 kHz to 10 kHz	0.057 % 0.054 %		
	2 V to 20 V 20 Hz to 1 kHz 1 kHz to 10 kHz	0.029 % 0.025 %		

Assessment Manager: DP4 Page 4 of 11



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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
AC VOLTAGE (continued)	20 V to 200 V 20 Hz to 1 kHz 1 kHz to 10 kHz 200 V to 1 kV 55 Hz to 1 kHz	0.041 % 0.031 % 0.046 %		А
Measurement (continued)	1 kHz to 10 kHz	0.047 %		
DC CURRENT				
Generation	0 μA to 330 μA 330 μA to 3.3 mA 3.3 mA to 33 mA 33 mA to 330 mA 330 mA to 1.1 A 1.1 A to 3 A 3 A to 11 A 11 A to 20.5 A	150 µA/A + 25 nA 110 µA/A + 100 nA 100 µA/A + 2.0 µA 100 µA/A + 20 µA 210 µA/A + 80 µA 390 µA/A + 1.0 mA 510 µA/A + 2.5 mA 0.10 % + 4.0 mA		
	10 A to 16.5 A	0.25 % + 3.0 mA	For the calibration of toroidal	
	16.5 A to 150 A 150 A to 1025 A	0.25 % + 1.0 A 0.25 % +1.5 A	clamp-on ammeters	
Measurement	0 μA to 200 μA 200 μA to 2 mA 2 mA to 20 mA 20 mA to 200 mA 200 mA to 2 A	75 µA/A + 1.4 nA 38 µA/A 55 µA/A 79 µA/A 92 µA/A		

Assessment Manager: DP4 Page 5 of 11



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United Kingdom Accreditation Service 2 Pine Trees, Chertsey Lane, Staines-upon-Thames, TW18 3HR, UK

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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
ELECTRICAL (continued)				А
DC Current (continued)				
AC CURRENT				
AC CURRENT Generation	29 µA to 330 µA 10 Hz to 20 Hz 20 Hz to 45 Hz 45 Hz to 1 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 10 kHz to 30 kHz 330 µA to 3.3 mA 10 Hz to 20 Hz 20 Hz to 45 Hz 45 Hz to 1 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 10 kHz to 30 kHz 3.3 mA to 33 mA 10 Hz to 20 Hz 20 Hz to 45 Hz 45 Hz to 10 kHz 10 kHz to 30 kHz 3.3 mA to 33 mA 10 Hz to 20 Hz 20 Hz to 45 Hz 45 Hz to 1 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 10 kHz to 30 kHz 33 mA to 330 mA 10 Hz to 20 Hz 20 Hz 20 Hz to 45 Hz 45 Hz to 1 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 10 kHz to 30 kHz 330 mA to 1.1 A 10 Hz to 45 Hz 45 Hz to 1 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 1 kHz to 5 kHz 5 kHz to 10 kHz 3 A to 11 A 45 Hz to 100 Hz 100 Hz to 11 kHz 3 A to 11 A 45 Hz to 100 Hz 100 Hz to 1 kHz	0.20 % + 730 nA 0.15 % + 700 nA 0.13 % + 700 nA 0.30 % + 700 nA 0.80 % + 870 nA 1.6 % + 2.0 μA 0.13 % + 2.0 μA 0.10 % + 2.0 μA 0.20 % + 2.0 μA 0.50 % + 2.2 μA 1.0 % + 2.5 μA 0.18 % + 10 μA 0.090 % + 10 μA 0.040 % + 10 μA 0.20 % + 15 μA 0.40 % + 15 μA 0.40 % + 100 μA 0.40 % + 100 μA 0.40 % + 100 μA 0.40 % + 100 μA 0.10 % + 2.0 μA 0.18 % + 100 μA 0.18 % + 100 μA 0.40 % + 15 μA 0.18 % + 780 μA 0.10 % + 300 μA 0.10 % + 300 μA 0.18 % + 780 μA 0.60 % + 1.8 mA 2.5 % + 6.0 mA		
	1 kHz to 5 kHz	3.0 % + 9.0 mA		

Assessment Manager: DP4 Page 6 of 11



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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
AC CURRENT (continued)				А
Generation (continued)	11 A to 20 A 45 Hz to 100 Hz 100 Hz to 1 kHz 1 kHz to 5 kHz	0.12 % + 15 mA 0.15 % + 15 mA 3.0 % + 15 mA		
	10 A to 16.5 A 45 Hz to 65 Hz	0.28 % + 3.0 mA	For the calibration of toroidal	
	65 Hz to 440 Hz	0.79 % + 3.0 mA	clamp-on ammeters	
	16.5 A to 150 A 45 Hz to 65 Hz	0.28 % + 13 mA	For the calibration of toroidal	
	65 Hz to 440 Hz	0.79 % + 13 mA	clamp-on ammeters	
	150 A to 1025 A 45 Hz to 65 Hz	0.28 % + 40 mA	For the calibration of toroidal	
	65 Hz to 440 Hz	0.79 % + 40 mA	clamp-on ammeters	
Measurement	20 nA to 200 µA 55 Hz to 1 kHz 1 kHz to 5 kHz	0.034 % + 2.0 nA 0.074 % + 2.0 nA		
	200 μA to 2 mA 55 Hz to 1 kHz 1 kHz to 5 kHz	0.23 % + 20 nA 0.67 % + 20 nA		
	2 mA to 20 mA 55 Hz to 1 kHz 1 kHz to 5 kHz	0.030 % + 200 nA 0.067 % + 200 nA		
	20 mA to 200 mA 55 Hz to 1 kHz 1 kHz to 5 kHz	0.031 % + 2.0 μA 0.064 % + 2.0 μA		
	0.2 A to 2 A 55 Hz to 1 kHz 1 kHz to 5 kHz	0.071 % + 20 μA 0.28 % + 20 μA		

Assessment Manager: DP4 Page 7 of 11



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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
ELECTRICAL (continued)				А
DC RESISTANCE				
Generation	0 Ω to 11 Ω 11 Ω to 33 Ω 33 Ω to 110 Ω 110 Ω to 330 Ω 330 Ω to 1.1 k Ω 1.1 k Ω to 3.3 k Ω 3.3 k Ω to 11 k Ω 11 k Ω to 33 k Ω 33 k Ω to 110 k Ω 110 k Ω to 330 k Ω 33 k Ω to 110 k Ω 110 k Ω to 330 k Ω 330 k Ω to 1.1 M Ω 1.1 M Ω to 3.3 M Ω 3.3 M Ω to 11 M Ω 11 M Ω to 33 M Ω 33 M Ω to 110 M Ω 110 M Ω to 330 M Ω 330 M Ω to 1.1 G Ω	40 $\mu\Omega/\Omega$ + 2.0 $m\Omega$ 30 $\mu\Omega/\Omega$ + 3.1 $m\Omega$ 28 $\mu\Omega/\Omega$ + 4.0 $m\Omega$ 28 $\mu\Omega/\Omega$ + 6.3 $m\Omega$ 28 $\mu\Omega/\Omega$ + 51 $m\Omega$ 28 $\mu\Omega/\Omega$ + 51 $m\Omega$ 28 $\mu\Omega/\Omega$ + 150 $m\Omega$ 28 $\mu\Omega/\Omega$ + 480 $m\Omega$ 28 $\mu\Omega/\Omega$ + 450 $m\Omega$ 32 $\mu\Omega/\Omega$ + 44 Ω 32 $\mu\Omega/\Omega$ + 14 Ω 32 $\mu\Omega/\Omega$ + 24 Ω 60 $\mu\Omega/\Omega$ + 110 Ω 130 $\mu\Omega/\Omega$ + 360 Ω 250 $\mu\Omega/\Omega$ + 4.1 $k\Omega$ 500 $\mu\Omega/\Omega$ + 19 $k\Omega$ 0.30 % + 230 $k\Omega$ 1.5 % + 1.2 $M\Omega$		
Measurement	$\begin{array}{c} 0 \ \Omega \ \text{to} \ 1 \ \Omega \\ 1 \ \Omega \ \text{to} \ 20 \ \Omega \\ 20 \ \Omega \ \text{to} \ 200 \ \Omega \\ 200 \ \Omega \ \text{to} \ 200 \ \Omega \\ 2 \ \text{k}\Omega \ \text{to} \ 20 \ \text{k}\Omega \\ 2 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 200 \ \text{k}\Omega \\ 200 \ \text{k}\Omega \ \text{to} \ 1 \ \text{G}\Omega \\ \end{array}$	21 $\mu\Omega/\Omega$ + 24 $\mu\Omega$ 36 $\mu\Omega/\Omega$ + 24 $\mu\Omega$ 10 $\mu\Omega/\Omega$ + 24 $\mu\Omega$ 14 $\mu\Omega/\Omega$ 16 $\mu\Omega/\Omega$ 14 $\mu\Omega/\Omega$ 22 $\mu\Omega/\Omega$ 41 $\mu\Omega/\Omega$ 0.030 %		
CALIBRATION OF CHARGE AMPLIFIERS	1 pC to 33 pC 200 mHz to 10 Hz 10 Hz to 45 Hz 63 Hz to 10 kHz 33 pC to 330 pC 200 mHz to 10 Hz 10 Hz to 45 Hz 63 Hz to 10 kHz	1.2 % 0.093 % + 0.0060 pC 0.020 % + 0.0060 pC 1.2 % 0.036 % + 0.0080 pC 0.020 % + 0.0080 pC		
	330 pC to 3300 pC 200 mHz to 10 Hz 10 Hz to 45 Hz 63 Hz to 10 kHz	1.2 % 0.036 % + 0.050 pC 0.020 % + 0.060 pC		
	3300 pC to 33000 pC 200 mHz to 10 Hz 10 Hz to 45 Hz 63 Hz to 10 kHz	1.2 % 0.036 % + 0.65 pC 0.020 % + 0.60 pC		
	33000 pC to 100000 pC 200 mHz to 10 Hz 10 Hz to 45 Hz 63 Hz to 10 kHz	1.2 % 0.024 % + 2.0 pC 0.025 % + 6.0 pC		

Assessment Manager: DP4 Page 8 of 11



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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
CALIBRATION OF CHARGE AMPLIFIERS (continued)				А
Attenuation				
With reference to a set value of 3 V	0 dB to 30 dB DC and 3 Hz to 10 kHz	0.020 dB		
TEMPERATURE SIMULATION				
Thermocouple type				
К	-200 °C to +1300 °C	0.30 °C	Including reference junction	
J N	-210 °C to +1200 °C -200 °C to +1300 °C	0.26 °C 0.36 °C	compensation	
T T	-250 °C to -150 °C -150 °C to +400 °C	0.31 °C 0.25 °C		
К	-200 °C to +1300 °C	0.23 °C	Excluding reference junction	
J N	-210 °C to +1200 °C -200 °C to +1300 °C	0.16 °C 0.30 °C	compensation	
T T	-250 °C to -150 °C -150 °C to +400 °C	0.23 °C 0.16 °C		
Platinum resistance thermometry				
Simulation	-50 °C to 800 °C	0.10 °C		
Measurement	-50 °C to 800 °C	0.10 °C		
FREQUENCY				
Generation	10 mHz to 30 MHz	2.0 in 10 ¹¹		
Measurement	1 mHz to 225 MHz	0.05 μHz/Hz		
ANGULAR VELOCITY				A
Calibration of angular velocity sensors			Ambient temperature 18 °C to 22 °C.	
Applied angular velocity	10 °/s to 2000 °/s	0.13 % of angular velocity		
Output voltage measurement	0 V to 200 mV 200 mV to 2 V 2 V to 20 V	560 μV/V + 150 μV 560 μV/V + 150 μV 560 μV/V + 170 μV		

Assessment Manager: DP4 Page 9 of 11



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Measured Quantity Instrument or Gauge	Range	Expanded Measurement Uncertainty (k = 2)	Remarks	Location Code
ELECTRICAL on site				В
Generation and measurement				
DC Volts	0 V to 60 V	12 μV/V + 5.0 μV		
DC Current	0 A to 40 mA	10 μΑ		
Resistance	0 Ω to 5 kΩ	30 μ Ω / Ω + 55 m Ω		
Frequency	1 Hz to 50 kHz	1.0 mHz		
TEMPERATURE SIMULATION				
Thermocouple type				
К	-200 °C to +1300 °C	0.33 °C	Including reference junction compensation	
J N	-210 °C to +1200 °C -200 °C to +1300 °C	0.28 °C 0.39 °C	Compensation	
T T	-250 °C to -150 °C -150 °C to +400 °C	0.33 °C 0.27 °C		
Κ	-200 °C to +1300 °C	0.25 °C	Excluding reference junction	
Ŋ	-210 °C to +1200 °C -200 °C to +1300 °C	0.18 °C 0.30 °C	compensation	
T T	-250 °C to -150 °C -150 °C to +400 °C	0.25 °C 0.18 °C		
Platinum resistance thermometry				
Simulation	-50 °C to 800 °C	0.12 °C		
Measurement	-50 °C to 800 °C	0.12 °C		
		END		

Assessment Manager: DP4 Page 10 of 11



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Appendix - Calibration and Measurement Capabilities

Introduction

The definitive statement of the accreditation status of a calibration laboratory is the Accreditation Certificate and the associated Schedule of Accreditation. This Schedule of Accreditation is a critical document, as it defines the measurement capabilities, ranges and boundaries of the calibration activities for which the organisation holds accreditation.

Calibration and Measurement Capabilities (CMCs)

The capabilities provided by accredited calibration laboratories are described by the Calibration and Measurement Capability (CMC), which expresses the lowest measurement uncertainty that can be achieved during a calibration. If a particular device under calibration itself contributes significantly to the uncertainty (for example, if it has limited resolution or exhibits significant non-repeatability) then the uncertainty quoted on a calibration certificate will be increased to account for such factors.

The CMC is normally used to describe the uncertainty that appears in an accredited calibration laboratory's schedule of accreditation and is the uncertainty for which the laboratory has been accredited using the procedure that was the subject of assessment. The measurement uncertainty is calculated according to the procedures given in the GUM and is normally stated as an expanded uncertainty at a coverage probability of 95 %, which usually requires the use of a coverage factor of k = 2. An accredited laboratory is not permitted to quote an uncertainty that is smaller than the published measurement uncertainty in certificates issued under its accreditation.

Expression of CMCs - symbols and units

It should be noted that the percentage symbol (%) represents the number 0.01. In cases where the measurement uncertainty is stated as a percentage, this is to be interpreted as meaning percentage of the measurand. Thus, for example, a measurement uncertainty of 1.5 % means $1.5 \times 0.01 \times q$, where q is the quantity value.

The notation Q[a, b] stands for the root-sum-square of the terms between brackets: $Q[a, b] = [a^2 + b^2]^{1/2}$

Assessment Manager: DP4 Page 11 of 11